

EMC TEST REPORT

Report Number: 101561028ATL-001 Project Number: G101561028

Report Issue Date: March 31, 2014 Report Revised Date: April 2, 2014

Product Designation: TJ6100-401 & TD6100-401 Current to Pressure Transducers

Standards: IEC 61000-4-2, IEC 61000-4-3, IEC 61000-4-4, IEC 61000-4-6, IEC 61000-4-8 per IEC 61326-1, 2012/07/10 Ed: 2

Tested by: Intertek Testing Services NA, Inc. 1950 Evergreen Blvd, Suite 100 Duluth, GA 30096 USA Client: Fairchild Industrial Products Company 3920 West Point Blvd. Winston-Salem, NC 27102 USA

Report prepared by:

Jeffrey D. Hiday / EMC Team Leader

Report reviewed by

The

Troy J. Ihle / Project Engineer

This report is for the exclusive use of Intertek's Client and is provided pursuant to the agreement between Intertek and its Client. Intertek's responsibility and liability are limited to the terms and conditions of the agreement. Intertek assumes no liability to any party, other than to the Client in accordance with the agreement, for any loss, expense or damage occasioned by the use of this report. Only the Client is authorized to permit copying or distribution of this report and then only in its entirety. Any use of the Intertek name or one of its marks for the sale or advertisement of the tested material, product or service must first be approved in writing by Intertek. The observations and test results in this report are relevant only to the sample tested. This report by itself does not imply that the material, product, or service is or has ever been under an Intertek certification program. Report Number: 101561028ATL-001

1 Introduction and Conclusion

The tests indicated in section 2.0 were performed on the product constructed as described in section 4.0. The remaining test sections are the verbatim text from the actual data sheets used during the investigation. These test sections include the test name, the specified test Method, a list of the actual Test Equipment Used, documentation Photos, Results and raw Data. No additions, deviations, or exclusions have been made from the standard(s) unless specifically noted.

Based on the results of our investigation, we have concluded the product tested **complies** with the requirements of the standard(s) indicated. The results obtained in this test report pertain only to the item(s) tested.

2 Test Summary

Section	Test full name	Result
3	Client Information	
4	Description of Equipment Under Test	
5	System Setup and Method	
6	Radiated Emissions (EN55011: 2008) Not tested	Not Tested
7	AC Mains Conducted Emissions (EN55011: 2008) This test is not applicable for DC powered devices	N/A
8	Harmonics This test is not applicable for DC powered devices	N/A
9	Flicker This test is not applicable for DC powered devices	N/A
10	Electro-Static Discharge Immunity Test (IEC 61000-4-2: 2 nd Edition: 2008)	Pass
11	Radiated, Radio-Frequency, Electromagnetic Immunity (IEC61000-4-3 2 nd Edition: 2010)	Pass
12	Electrical Fast Transient/Burst Immunity Test (IEC61000-4-4 3 rd Edition: 2012)	Pass
13	Immunity to Surges (IEC61000-4-5 2 nd Edition: 2009)	Pass
14	Conducted, Radio-Frequency, Electromagnetic Immunity Test (IEC61000-4-6 4 th Edition: 2013)	Pass
15	Power Frequency Magnetic Field Immunity Test (IEC61000-4-8 2 nd Edition: 2009)	Pass
16	Voltage Dips/Interruptions Immunity Test This test is not applicable for DC powered devices	N/A
17	Revision History	

Report Number: 101561028ATL-001

3 Client Information

This EUT was tested at the request of:

Client:	Fairchild Industrial Products Company
	3920 West Point Blvd.
	Winston-Salem, NC 27102, USA
Contact:	Mr. Stan Przbylowicz
Telephone:	(336) 659-3456
Email:	stanp@fairchildproducts.com

4 Description of Equipment Under Test

Manufacturer:	Fairchild Industrial Products Company
	3920 West Point Blvd.
	Winston-Salem, NC 27102, USA

Equipment Under Test			
Description	Manufacturer	Model Number	Serial Number
Electro-Pneumatic	Fairchild Industrial	TD6100-401	0214836
Transducers	Products Company		
Electro-Pneumatic	Fairchild Industrial	TJ6100-401	0214838
Transducers	Products Company		

Receive Date:	03/06/2014
Received Condition:	Good
Type:	Production

Description of Equipment Under Test (provided by client)

The Model T6100 series Lock in place Electro-Pneumatic I/P Transducer uniquely lock in last place feature provides flexibility, reliability, and safety applications requiring protection from signal failures to critical control systems instruments. The design of the T6100 relies on a proprietary integrated solenoid valve module interposed between the flapper- nozzle pilot and the booster section. Upon signal failure and electrical charge stored within the active electronic module maintains the to the voice coil at the last set-point. Simultaneously, a high energy pulse closes the solenoid valve, trapping the signal pressure within the signal chamber at the last set-point. The booster continues to provide its normal forward and exhaust flow, with the constant signal pressure now captured and maintained within the signal chamber.

Equipment Under Test Power Configuration			
Rated Voltage	Rated Current	Rated Frequency	Number of Phases
Not Listed	12 mA	DC	DC

Operating modes of the EUT:

No.	Descriptions of EUT Exercising
1	The primary operation of the EUT is to output a pressure signal proportional to the input current signal, 4 to 20mA.
2	The secondary operation of the device is to recognize a loss of power and to lock the output pressure at the last known good point.

Software used by the EUT:

No.	Descriptions of EUT Exercising
1	None

5 System Setup and Method

		Cable	S		
ID	Description	Length (m)	Shielding	Ferrites	Termination
A	Air Supply	7.6m	No	No	Air Pressure Valve
В	Air In	5.5m	No	No	TD61000- 401
С	Air In	4.7m	No	No	TJ6100- 401
D	+12mA Current Source	14.6m	Yes	No	TD61000- 401
Е	+12mA Current Source	14.6m	Yes	No	TJ6100- 401
F	Air Out	5m	No	No	Heise
G	Air Out	5m	No	No	Heise

Support Equipment			
Description	Manufacturer	Model Number	Serial Number
Current Source	Altek Industries Corp.	334A	1604065
Current Source	Fairchild	ET-500	I/P031
Digital Pressure Meter	Heise	PM	41636
Pneumatic Regulator	Fairchild	M10262	0214
Pressure Gauge	Fairchild	G-2062	ATL1403061056-001

5.1 Method:

Configuration as required by Standard taking Precedence.

5.2 EUT Block Diagram:



5.3 EUT Performance Criteria and Monitoring:

Performance as required by Standard taking Precedence.

Product Specific Performance:

No.	Description
1	Test Procedures supplied by the client were followed in Table's 1, 2a ,2b, 2c were followed for each test. To summarized these procedures for verifying the lock in last place: a) adjust
2	a) adjust the current source output to 100%, then return to 50% setting (output pressure must follow the input change)
3	 b) disconnect the positive current signal lead (output pressure must remain within 5% of original pressure value)
4	c) reconnect the positive current signal line and adjust the current source to 50% (output pressure must follow the input change)

Description of how performance was observed during testing:

No.	Description
1	Pressure gauge readings were observed on the Heise, 2 channel, Digital Pressure Meter throughout
	testing to validate the functionally of the EUT(s).

General notes:

Report Number: 101561028ATL-001

6 Radiated Emissions

6.1 Method

Tests are performed in accordance with IEC 61326-1, 2012/07/10 Ed: 2.

TEST SITE: 10m Semi-Anechoic Chamber

10 Meter Semi-Anechoic Chamber The test site for radiated emissions is located at 1950 Evergreen Blvd, Suite 100, Duluth, Georgia 30096. It is a 10 meter semi-anechoic chamber manufactured by Panashield. Embedded in the floor is a 3 meter diameter turntable.

Measurement Uncertainty

For radiated emissions, U_{lab} (3.9 dB at 3m and 3.6 dB at 10m below 1 GHz, and 4.2 dB at 3m above 1

GHz) < U_{CISPR} (5.2 dB), which is the reference value in CISPR 16-4-2 Table 1, hence the compliance of the product is only based on the measured value, and no measurement uncertainty correction is required, based on CISPR 22 and CISPR 11 (for 2006 and later revisions) Clause 11.

Sample Calculation

The field strength is calculated by adding the Antenna Factor and Cable Factor, and subtracting the Amplifier Gain (if any) from the measured reading. The basic equation with a sample calculation is as follows:

 $\begin{array}{ll} FS = RA + AF + CF - AG \\ Where & FS = Field \ Strength \ in \ dB\mu V/m \\ RA = Receiver \ Amplitude \ (including \ preamplifier) \ in \ dB\mu V \\ CF = Cable \ Attenuation \ Factor \ in \ dB \\ AF = Antenna \ Factor \ in \ dB \\ AG = Amplifier \ Gain \ in \ dB \end{array}$

In the following table(s), the reading shown on the data table reflects the preamplifier gain. An example for the calculations in the following table is as follows.

Assume a receiver reading of 52.0 dB μ V is obtained. The antenna factor of 7.4 dB and cable factor of 1.6 dB is added. The amplifier gain of 29 dB is subtracted, giving a field strength of 32 dB μ V/m. This value in dB μ V/m was converted to its corresponding level in μ V/m.

 $RA = 52.0 \text{ dB}\mu\text{V} \\ AF = 7.4 \text{ dB/m} \\ CF = 1.6 \text{ dB} \\ AG = 29.0 \text{ dB} \\ FS = 32 \text{ dB}\mu\text{V/m} \\ \label{eq:result}$

To convert from $dB\mu V$ to μV or mV the following was used:

 $UF = 10^{(NF/20)}$ where UF = Net Reading in μV NF = Net Reading in $dB\mu V$

Example:

FS = RA + AF + CF - AG = 52.0 + 7.4 + 1.6 - 29.0 = 32.0 $UF = 10^{(32 \ dB\mu V / 20)} = 39.8 \ \mu V/m$

6.2 Test Equipment Used:

Asset	Description	Manufacturer	Model	Serial	Cal Date	Cal Due
N/A						

Software Utilized:

Name	Manufacturer	Version
N/A		

6.3 Results:

The sample was not tested for radiated emissions at the client's request.

7 AC Mains Conducted Emissions

7.1 Method

Tests are performed in accordance with IEC 61326-1, 2012/07/10 Ed: 2.

TEST SITE:

The EMC Lab has one Semi-anechoic Chamber and one Shielded Chamber. AC Mains Power is available at 120, 230, and 277 Single Phase; 208, 400, and 480 3-Phase. Large reference ground-planes are installed in the general lab area to facilitate EMC work not requiring a shielded environment.

10 Meter Semi-Anechoic Chamber The test site for radiated emissions is located at 1950 Evergreen Blvd, Suite 100, Duluth, Georgia 30096. It is a 10 meter semi-anechoic chamber manufactured by Panashield. Embedded in the floor is a 3 meter diameter turntable.

Measurement Uncertainty

For conducted emissions, U_{lab} (2.8 dB in worst case) < U_{CISPR} (3.6 dB), which is the reference value in CISPR 16-4-2 Table 1, hence the compliance of the product is only based on the measured value, and no measurement uncertainty correction is required, based on CISPR 22 and CISPR 11 (for 2006 and later revisions) Clause 11.

Sample Calculations

The following is how net line-conducted readings were determined:

$$\label{eq:NF} \begin{split} \mathsf{NF} &= \mathsf{RF} + \mathsf{LF} + \mathsf{CF} + \mathsf{AF} \\ \text{Where} \quad \mathsf{NF} &= \mathsf{Net} \ \mathsf{Reading} \ \mathsf{in} \ \mathsf{dB}\mu\mathsf{V} \\ \mathsf{RF} &= \mathsf{Reading} \ \mathsf{from} \ \mathsf{receiver} \ \mathsf{in} \ \mathsf{dB}\mu\mathsf{V} \\ \mathsf{LF} &= \mathsf{LISN} \ \mathsf{or} \ \mathsf{ISN} \ \mathsf{Correction} \ \mathsf{Factor} \ \mathsf{in} \ \mathsf{dB} \\ \mathsf{CF} &= \mathsf{Cable} \ \mathsf{Correction} \ \mathsf{Factor} \ \mathsf{in} \ \mathsf{dB} \\ \mathsf{AF} &= \mathsf{Attenuator} \ \mathsf{Loss} \ \mathsf{Factor} \ \mathsf{in} \ \mathsf{dB} \end{split}$$

To convert from dBµV to µV or mV the following was used:

 $UF = 10^{(NF \, / \, 20)} \text{ where } UF = Net \text{ Reading in } \mu V$ $NF = Net \text{ Reading in } dB \mu V$

Example:

 $\begin{array}{l} NF = RF + LF + CF + AF = 28.5 + 0.2 + 0.4 + 20.0 = 49.1 \ dB\mu V \\ UF = 10^{(49.1 \ dB\mu V \, / \, 20)} = 285.1 \ \mu V/m \end{array}$

7.2 Results:

The sample was not tested because the EUT is DC powered and does not connect to the AC mains.

Report Number: 101561028ATL-001

8 Electrostatic Discharge Immunity Test

8.1 Method

Tests are performed in accordance with IEC 61326-1, 2012/07/10 Ed: 2.

TEST SITE: Duluth, GA

The EMC Lab has one Semi-anechoic Chamber and one Shielded Chamber. AC Mains Power is available at 120, 230, and 277 Single Phase; 208, 400, and 480 3-Phase. Large reference ground-planes are installed in the general lab area to facilitate EMC work not requiring a shielded environment.

8.2 Test Equipment Used:

Asset	Description	Manufacturer	Model	Serial	Cal Date	Cal Due
014450	Electrostatic Discharge Simulator (ESD)	Noiseken	ESS-200AX	5079C00055	04/08/2013	04/08/2014
211511	Electrostatic Discharge Gun (ESD)	NoiseKen	TC-815P	ESS0361872	04/08/2013	04/08/2014
213119	Vertical Coupling Plane	Intertek	ESD-VCP	none	VBU	Verified
211897	Digital Pocket Thermometer and Hydrometer	Mannix	SAM700BAR	none	12/27/2013	12/27/2014
213047	Multimeter	Fluke	87	65290209	01/09/2014	01/09/2015

Software Utilized:

Name	Manufacturer	Version
Not Applicable	Not Applicable	Not Applicable

8.3 Results:

The sample tested was found to Comply.

8.4 Setup Photographs:







Report Number: 101561028ATL-001









Report Number: 101561028ATL-001







Report Number: 101561028ATL-001

8.5	Data:
0.0	Data.

Teet	Discharge				Test \	/oltages	s, Polari	ties and	d Resul	t Class	sificatior	۱		
Point	Voltage	2	kV	4	kV	6	kV	8	kV	d)	15	kV		kV
rom	Туре	Pos	Neg	Pos	Neg	Pos	Neg	Pos	Neg	Š	Pos	Neg	Pos	Neg
HCP	Contact	A(1)	A(1)	A(1)	A(1)	A(1)	A(1)			ab				
Front : Edge	Contact	A(2)	A(2)	A(2)	A(2)	A(2)	A(2)			only /				
VCP :	Contact	A(3)	A(3)	A(3)	A(3)	A(3)	A(3)			ges K				
1-6	Contact	Α	A	A	A	A	: A			arg				
7-14	Contact	A	A	A	A	A	A			sch				
15-21 :	Contact	A	: A	: А	: A	: A	: A :		:	Ö				
22-28 :	Contact	A	: A	: A	: A	: A	: A :		:	2ir				
28-38	Contact	А	А	А	А	А	А			`				
т	Test Personnel: MJA Test Date: 03/17/2014													
Supervis	sing/Reviewing													
	Engineer:						_				_			
(Wh	ere Applicable)	TJI	4000.4			_	R	equired	Perform	ance:	<u>B</u>			
Pro	duct Standard:	12mA	1326-1 (DC)			Test Levels: <u>6kV C</u>			6KV C0	ntact and	I 8KV AIr			
	input Current.	12111A				_	A	Ambient	Temper	ature:	22.3 °C			
Wavefo	orm Verified on					Polotivo Humidity: 41.5 %								
47	Oscilloscope:	Yes				_	^	tracanh		nunty.	41.0 /0	ahara		
47	Verified:	955k	Ohms			_	μ	unosph	enc Pres	sure:	973.5 N	nuars		

Notes: Applied 3 second delay between ESD discharges. No Air discharge points.

- (1) Discharge to Horizontal Coupling Plane, 4 locations
- (2) Discharge to front edge of Horizontal Coupling Plane
- (3) Discharge to Vertical Coupling Plane, 4 locationsThe EUT met the requirements without any degradation of performance.

Deviations, Additions, or Exclusions: None

9 Radiated, radio-frequency, electromagnetic field immunity test

9.1 Method

Tests are performed in accordance with IEC6100-4-3.

TEST SITE: Duluth, GA

The EMC Lab has one Semi-anechoic Chamber and one Shielded Chamber. AC Mains Power is available at 120, 230, and 277 Single Phase; 208, 400, and 480 3-Phase. Large reference ground-planes are installed in the general lab area to facilitate EMC work not requiring a shielded environment.

9.2 Test Equipment Used:

Asset	Description	Manufacturer	Model	Serial	Cal Date	Cal Due
200063	Power Meter	Boonton	4232A	120802	02/27/2014	02/27/2015
015681	Signal Generator, 5kHz-3.3GHz	Rohde & Schwarz	SMT 03	844933/040	12/02/2013	12/02/2014
200001	Attenuator, 20 dB, <18GHz	Weinschel Corp	2	BK1848	12/04/2013	12/04/2014
200160	Power Sensor	Boonton	51011-EMC	35991	02/27/2014	02/27/2015
213008	Antenna, Biconlog, 80-1000MHz	EMCO	3143	9404-1031	VBU	Verified
200142	Isotropic Field Probe (10MHz-40GHz)	ETS-Lindgren	HI-6053	00133447	02/13/2014	02/13/2015
BBA100	Broadband Amplifier	Rohde & Schwarz	R&S BBA100	101172-1	VBU	Verified

Software Utilized:

Name	Manufacturer	Version
Tile	Quantum Change	3.4.K.22

9.3 Results:

The sample tested was found to Comply.

9.4 Setup Photographs:



9.5 Data:

Field	Frequency		Antenna Polarity, Azimuths and Result Classification						
Level	Range		Ver	tical			Horiz	zontal	
(V/m)	MHz	0	90	180	270	0	90	180	270
10	80 to 1000 200, 400, 600, 800, 1000	А	А	А	А	A	А	А	А
3	1400 to 2000 1600, 1800, 2000	Α	Α	Α	Α	А	А	А	A
1	2000 to 2700 2200, 2400, 2700	A	А	А	А	А	А	А	А

Test Personnel:	JDH	Test Date:	03/12/2014 & 3/15/2014
Supervising/Reviewing Engineer: (Where Applicable)	ILT	Modulation: Required Performance:	80 % AM
Product Standard: Input Current:	IEC 61326-1, 2012/07/10 Ed: 2 12.0mA (DC)	Test Levels:	See Table Above
	· · ·	Ambient Temperature:	24 °C
Field Level Monitored:	Yes	Relative Humidity:	33 %
		Atmospheric Pressure:	967xx mbars

Notes:

(1) The EUT met the requirements without any degradation of performance.

Deviations, Additions, or Exclusions: None

10 Electrical Fast Transient/Burst Immunity Test

10.1 Method

Tests are performed in accordance with IEC 61326-1, 2012/07/10 Ed: 2.

TEST SITE: Duluth, GA

The EMC Lab has one Semi-anechoic Chamber and one Shielded Chamber. AC Mains Power is available at 120, 230, and 277 Single Phase; 208, 400, and 480 3-Phase. Large reference ground-planes are installed in the general lab area to facilitate EMC work not requiring a shielded environment.

10.2 Test Equipment Used:

Asset	Description	Manufacturer	Model	Serial	Cal Date	Cal Due
012906	EMC Immunity Test System	KeyTek	EMC Pro Plus	0601240	10/15/2013	10/15/2014
213195	Coupling Clamp	Compliance Design	801-4-CC	none	VBU	Verified
T006217	THDX	Oregon Scientific	BA888	NSN	12/11/2013	12/11/2014
211678	Power Supply	Tektronix	PS2510G	TW50295	VBU	Verified

Software Utilized:

Name	Manufacturer	Version
CEWARE	KeyTek	CEW32

10.3 Results:

The sample tested was found to Comply.

10.4 Setup Photographs:



10.5 Test Data:

			Test Voltages, Polarities, and Result Classification								
Test	Coupling	Coupling 0.25kV		0.5kV		1 kV		2 kV		4 kV	
Point	Method	pos	neg	pos	neg	pos	neg	pos	neg	pos	neg
12mA (DC) on TD6100-4	01 Clamp	: A	A	A	A	A	A	A	Α		
12mA (DC) on TJ6100-4	1 Clamp	А	А	А	А	А	А	А	А		
Test Personnel: JDH Test D						Date:	03/15/2	014			
Supervising/Reviewing Engineer:				Pul	se Repetit Require	ion Frequ d Perform	uency: _	<u>5kHz</u> B			
Product Standard: IE Input Current: 1	n <u>C 61326-1, 2012/07</u> 2.0mA (DC)	7/10 Ed: 2 Test Levels: See Table Above			e						

Waveform Verified on Oscilloscope: <u>Yes</u>

Relative Humidity: Atmospheric Pressure:

Ambient Temperature:

23 °C

24 %

984 mbars

Notes:

(1) The EUT met the requirements without any degradation of performance.

Deviations, Additions, or Exclusions: None

Report Number: 101561028ATL-001

11 Immunity to Surge

11.1 Method

Tests are performed in accordance with IEC 61326-1, 2012/07/10 Ed: 2.

TEST SITE: Duluth, GA

The EMC Lab has one Semi-anechoic Chamber and one Shielded Chamber. AC Mains Power is available at 120, 230, and 277 Single Phase; 208, 400, and 480 3-Phase. Large reference ground-planes are installed in the general lab area to facilitate EMC work not requiring a shielded environment.

11.2 Test Equipment Used:

Asset	Description	Manufacturer	Model	Serial	Cal Date	Cal Due
012906	EMC Immunity Test System	KeyTek	EMC Pro Plus	0601240	10/15/2013	10/15/2014
213288	Oscilloscope, Digital Real-Time	Tektronix	TDS680C	B020153	11/05/2013	11/05/2014
T006217	THDX	Oregon Scientific	BA888	NSN	12/11/2013	12/11/2014

Software Utilized:

Name	Manufacturer	Version
CEWare	Keytek	3.2

11.3 Results:

The sample tested was found to Comply.

11.1 Setup Photographs:



11.2 Test Data:

		Test Voltages, Polarities, and Result Classification							
	0.	.5kV	1	kV	2k	XV	4	٨V	
Test	pos	neg	pos	neg	pos	neg	pos	neg	
12mA (DC) on TD6100-	•	-		-	: :		:		
401, L-PE	A	A	A	A	:				
12mA (DC) on TJ6100-40)1,								
L-PE	A	A	A	A	i i				
Test Personnel: JI	DH, MJA				Test Date	: 03/19/20	14		
Supervising/Reviewing									
Engineer:									
(Where Applicable) <u>T</u>	JI								
Product Standard: IE	C 61326-1, 2012	/07/10 Ed: 2	_		Test Levels	: See Tab	le Above		
Input Current: 12	2.0mA (DC)		Performance Criteria: See Report Section 5.3					.3	
Waveform Verified on				Ambient	Temperature	: 23 °C			
Oscilloscope: Y	ES			Rela	ative Humidity	: 27 %			
	an.		_	Atmosph	eric Pressure	: 984 mba	rs		

Notes:

(1) The EUT met the requirements without any degradation of performance.

Deviations, Additions, or Exclusions: None

12 Conducted, radio-frequency, electromagnetic field immunity test

12.1 Method

Tests are performed in accordance with IEC 61326-1, 2012/07/10 Ed: 2.

TEST SITE: Duluth, GA

The EMC Lab has one Semi-anechoic Chamber and one Shielded Chamber. AC Mains Power is available at 120, 230, and 277 Single Phase; 208, 400, and 480 3-Phase. Large reference ground-planes are installed in the general lab area to facilitate EMC work not requiring a shielded environment.

12.2 Test Equipment Used:

Asset	Description	Manufacturer	Model	Serial	Cal Date	Cal Due
003178*	Power Meter	Boonton	4321A	36701	04/03/2013	04/03/2014
011405	Signal Generator, 10kHz-990MHz	Hewlett Packard	8656B	3050U09746	07/17/2013	07/17/2014
18703	75 Watt Amplifier, 10kHz-220MHz	Amplifier Research	75A220	15964	CNR	CNR
200147*	EM Injection Clamp (10kHz-1GHz)	Fischer Custom Commu	F-2031-23mm	120442	04/03/2013	04/03/2014
200125*	Power Sensor, Dual Diode, 10kHz to 8GHz	Boonton	51011-EMC	34915	03/06/2014	03/06/2015
T006217	THDX	Oregon Scientific	BA888	NSN	12/11/2013	12/11/2014

Software Utilized:

Name	Manufacturer	Version
Tile	Quantum Change	3.4.K.22

12.3 Results:

The sample tested was found to Comply.

12.4 Setup Photographs:



12.5 Test Data:

Injection Device Type	Port Description	Test Level (Vrms)	Result Classification
Clamp	12mA (DC) on TD6100-401	3	А
Clamp	12mA (DC) on TJ6100-401	3	А

Test Personnel:	JDH	Test Date:	03/15/2014
Supervising/Reviewing		Modulation:	80%
(Where Applicable)	TJI	Required Performance:	A
Product Standard:	IEC 61326-1,2012/07/10 Ed:2	Test Levels:	See Table Above
Input Current:	12mA (DC)		
Test Level Verification		Ambient Temperature:	23.5 ℃
Performed:	Yes - calibrated	Relative Humidity:	25 %
		Atmospheric Pressure:	985 mbars

Notes:

(1) The EUT met the requirements without any degradation of performance.

Deviations, Additions, or Exclusions: None

13 Power Frequency Magnetic Field Immunity Test

13.1 Method

Tests are performed in accordance with IEC 61326-1, 2012/07/10 Ed: 2.

TEST SITE: Duluth, GA

The EMC Lab has one Semi-anechoic Chamber and one Shielded Chamber. AC Mains Power is available at 120, 230, and 277 Single Phase; 208, 400, and 480 3-Phase. Large reference ground-planes are installed in the general lab area to facilitate EMC work not requiring a shielded environment.

13.2 Test Equipment Used:

Asset	Description	Manufacturer	Model	Serial	Cal Date	Cal Due
	Double Voltage & Frequecy Tester AC Source			6408-		
211297	304/308	Combinova	6408-1	1000172	VBU	Verified
213197	ELF Field Monitor	Walker Scientific In	ELF-60D	K71959-13	01/29/2014	01/29/2015
200024	Loop, Radiating, 30 A/m	Intertek	1000-4-8-1	575	VBU	Verified
211897	Digital Pocket Thermometer and Hydrometer	Mannix	SAM700BAR	none	12/27/2013	12/27/2014
213047	Multimeter	Fluke	87	65290209	01/09/2014	01/09/2015

Software Utilized:

Name	Manufacturer	Version		
Not Applicable	Not Applicable	Not Applicable		

13.3 Results:

The sample tested was found to Comply.

13.4 Setup Photographs:



At 50 Hertz





At 60Hertz



Report Number: 101561028ATL-001



At 60 Hertz



13.5 Test Data:

		Test Level	Frequency	Re	sult Classification			
Test Location/ Mo	ode/ EUT Input	(A/m)	(Hz)	X – Axis	Y – Axis	Z – Axis		
Enclosure/ Operat	ing/ 12mA (DC)	30	50	А	А	А		
Enclosure/ Operat	ing/ 12mA (DC)	30	60	А	А	А		
Test Personnel:	MJA			Test Date:	03/17/2014			
Supervising/Reviewing Engineer: (Where Applicable) Product Standard:	TJI IEC 61326-1		Require	ed Performance: Test Levels:	A See Table Abov	e		
Input Current: Ambient Field Level: Test Field Level Verified:	12mA (DC) 0.6 milliGauss		Ambie Re Atmos	ent Temperature: elative Humidity: pheric Pressure:	22.3 °C 42.8 % 974.5 mbars			

Notes: Both models, TD6100-401 and TJ6100-401 tested.

(1) The EUT met the requirements without any degradation of performance.

Deviations, Additions, or Exclusions: None

Report Number: 101561028ATL-001

14 Voltage Dips / Interruptions Immunity Tests

14.1 Method

Tests are performed in accordance with IEC 61326-1, 2012/07/10 Ed: 2.

TEST SITE: Duluth, GA

The EMC Lab has one Semi-anechoic Chamber and one Shielded Chamber. AC Mains Power is available at 120, 230, and 277 Single Phase; 208, 400, and 480 3-Phase. Large reference ground-planes are installed in the general lab area to facilitate EMC work not requiring a shielded environment.

14.2 Test Equipment Used:

Asset	Description	Manufacturer	Model	Serial	Cal Date	Cal Due

Software Utilized:

Name	Manufacturer	Version
N/A		

14.3 Results:

The sample was not tested for immunity to voltage dips because the EUT does not connect to the AC mains.

15 Revision History

Revision Level	Date	Report Number	Prepared By	Reviewed By	Notes
0	03/31/2014	101561028ATL-001	JDH	TĴI	Original Issue
1	04/01/2014	101561028ATL-001	MJA	TJI	On all Test Data pages, Input Voltage changed to Input Current: 12mA (DC), Surge testing performed at +/-1kV.